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Aim and Scope

Our Journal provides a chance for academic and industry professionals to discuss recent progress in the area of security technology for smart device.

To bridge the gap of users who do not have access to major databases where one should pay for every downloaded article; this online publication platform is open to all readers as part of our commitment to global scientific society.

Journal Topics

The main topics include but will not be limited to: (Excellent surveying works, summary or introduction of new or fresh idea in these areas are welcome, too).

- Security Policy, Strategy and Management for Smart Devices
- Authentication and Identity Management for Smart Devices
- Security Education and Training for Smart Devices
- Personnel Security and Privacy for Smart Devices
- Trust Negotiation, Establishment and Management for Smart Devices
- Vulnerability, Threat, and Risk Analysis for Smart Devices
- Agent and Code Security for Smart Devices
- Authorization and Access Control for Smart Devices
- Biometrics Security and Applications for Smart Devices
- Forensics for Smart Devices
- Cryptographic Protocols for Smart Devices
- Data Integrity and Privacy for Smart Devices

- Database Security for Smart Devices
- Intrusion Detection and Prevention for Smart Devices
- Distributed System Security for Smart Devices
- Key Management and Recovery for Smart Devices
- Operating System Security for Smart Devices
- Secure Hardware and Software Design for Smart Devices
- Chip Security for Smart Devices
- E-Commerce Security for Smart Devices
- Intellectual Property Protection for Smart Devices
- Internet and Web Services Security for Smart Devices

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